

<b>Notice of References Cited</b>	Application/Control No. 10/809,278	Applicant(s)/Patent Under Reexamination YAMANE ET AL.	
	Examiner Emeka D. Iwuchukwu	Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0004922	01-2006	Lahti et al.	709/227
*	B	US-2003/0120496	06-2003	Alfred et al.	705/1
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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	K	US-			
	L	US-			
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**FOREIGN PATENT DOCUMENTS**

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